

# Octal Line Receiver

### **FEATURES**

- Meets EIA 232E/423A/422A and CCITT V.10,V.11, V.28, X.26, X.27
- Single +5V Supply--TTL Compatible Outputs
- Differential Inputs Withstand ± 25V
- Low Open Circuit Voltage for Improved Failsafe Characteristic
- Reduced Supply Current--35 mA Max
- Input Noise Filter
- Internal Hysteresis

#### **DESCRIPTION**

The UC5180C is an octal line receiver designed to meet a wide range of digital communications requirements as outlined in EIA standards EIA232E, EIA423A, EIA422A, and CCITT V.10, V.11, V.28, X.26, and X.27. The UC5180C includes an input noise filter and is intended for applications employing data rates up to 200 KBPS. A failsafe function allows these devices to "fail" to a known state under a wide variety of fault conditions at the inputs.

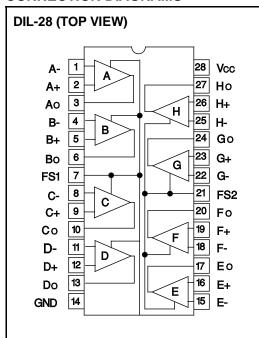
### **ABSOLUTE MAXIMUM RATINGS** (Note 1)

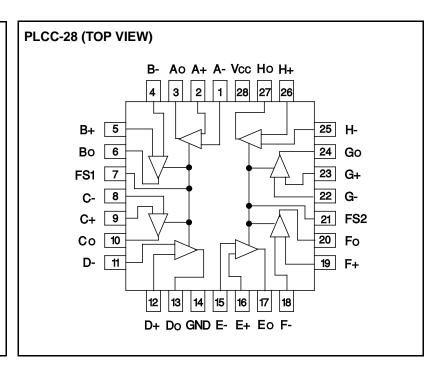
| Supply Voltage, Vcc                        | 7V              |
|--|-----------------|
| Output Sink Current                        | 50 mA           |
| Output Short Circuit Time                  | 1 Sec           |
| Common Mode Input Range                    | 15V             |
| Differential Input Range                   | 25V             |
| Failsafe Voltage                           | 0.3 to Vcc      |
| PLCC Power Dissipation, TA = 25°C (Note 2) |                 |
| DIP Power Dissipation, TA = 25°C (Note 2)  | 1200 mW         |
| Storage Temperature Range                  | -65°C to +150°C |
| Lead Temperature (Soldering, 10 Seconds)   | 300°C           |
|  |                 |

Note 1: All voltages are with respect to ground, pin 14. Currents are positive into, negative out of the specified terminal

Note 2: Consult Packaging Section of Databook for thermal limitations and considerations of package.

## **CONNECTION DIAGRAMS**





**DC ELECTRICAL CHARACTERISTICS:** Unless otherwise stated these specifications apply for TA =  $0^{\circ}$ C to + $70^{\circ}$ C, Vcc = 5V  $\pm$  5%, Input Common Mode Range  $\pm$  7V, TA =TJ

| PARAMETERS                      | RAMETERS SYMBOL TEST CONDITIONS |  |   |                   | UC5180C |      | UNITS |
|---------------------------------|---------------------------------|--|---|-------------------|---------|------|-------|
|                                 |                                 |  |   |                   | MIN     | MAX  |       |
| DC Input Resistance             | RIN                             | 3V ≤   Vin   ≤ 25V                           |   |                   | 3       | 7    | kΩ    |
| Failsafe Output Voltage         | Vors                            | Inputs Open or Shorted                       | One Input $0 \ge IOUT \ge -400 \mu A$ , |                   |         | 0.45 | V     |
|                                 |                                 | Together, or One Input Open and One Grounded |   |                   | 2.7     |      |       |
| Differential Input High         | VTH                             | VOUT = $2.7V$ , IOUT = $440 \mu A$           | Vout = 2.7V, lout = 440 μA              |                   | 50      | 200  | mV    |
| Threshold                       |                                 | (See Figure 1)                               |   | Rs = 500 (Note 2) |         | 400  |       |
| Differential Input Low          | VTL                             | Vout = 0.45V, lout = 440 mA                  |   | Rs = 0 (Note 2)   | -200    | -50  | mV    |
| Threshold                       |                                 | (See Figure 1)                               |   | Rs = 500 (Note 2) | -400    |      |       |
| Hysteresis                      | VH                              | Fs = 0V or Vcc (See Figure 1)                |   | 50                | 140     | mV   |       |
| Open Circuit Input Voltage      | Vicc                            |  |   |                   |         | 75   | mV    |
| Input Capacitance               | Cı                              |  |   |                   |         | 20   | pF    |
| High Level Output Voltage       | Vсн                             | VID = 1V, IOUT = - 440μA                     |   | 2.7               |         | V    |       |
| Low Level Output Voltage        | Vol                             | VID = -1V IOU                                |   | IOUT = 4 mA       |         | 0.4  | V     |
|                                 |                                 | (Note 3)                                     |   | IOUT = 8 mA       |         | 0.45 |       |
| Short Circuit Output<br>Current | los                             | Note 4                                       |   | 20                | 100     | mA   |       |
| Supply Current                  | Icc                             | 4.75V ≤ Vcc ≤ 5.25V                          |   |                   | 35      | mA   |       |
| Input Current                   | lin                             | Other Inputs Grounded                        |   | VIN = +10V        |         | 3.25 | mA    |
|                                 |                                 |  |   | VIN = -10V        | -3.25   |      |       |

Note 2: Rs is a resistor in series with each input.

Note 3: Measured after 100ms warm up (at 0°C)

Note 4: Only 1 output may be shorted at one time and then only for a maximum of 1 sec.

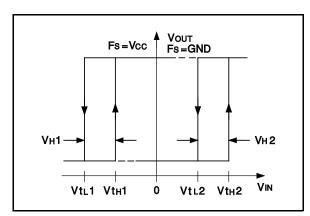


Figure 1. VtL, VtH, VH Definition

## AC ELECTRICAL CHARACTERISTICS: $Vcc = 5V \pm 5\%$ , Ta = 0°C to + 70°C, Figure 2, Ta = TJ.

| PARAMETERS                      | SYMBOL | TEST CONDITIONS                                  | UC5180C |     | UNITS |
|---------------------------------|--------|--|---------|-----|-------|
|                                 |        |  | MIN     | MAX |       |
| Propagation Delay - Low to High | tplh   | $CL = 50pF, VIN = \pm 500mV$                     |         | 550 | ns    |
| Propagation Delay - High to Low | tPHL   | $CL = 50pF, VIN = \pm 500mV$                     |         | 550 | ns    |
| Acceptance Input Frequency      | fA     | Unused Input Grounded, $VIN = \pm 200 \text{mV}$ |         | 0.1 | MHz   |
| Rejectable Input Frequency      | fR     | Unused Input Grounded, VIN = ± 500mV             | 5.5     |     | MHz   |

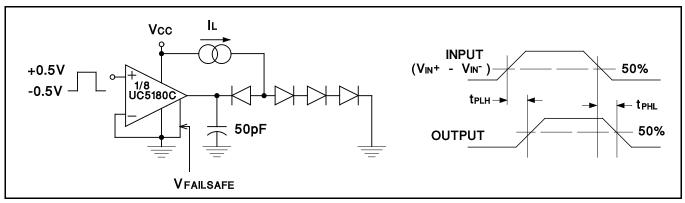


Figure 2. AC Test Circuit

#### **APPLICATIONS INFORMATION**

#### **Failsafe Operation**

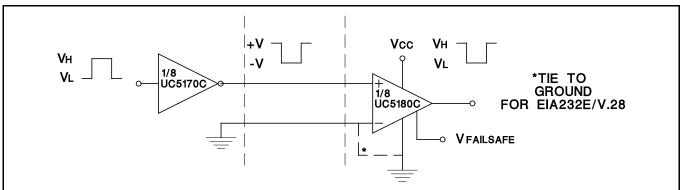
These devices provide a failsafe operating mode to guard against input fault conditions as defined in EIA422A and EIA423A standards. These fault conditions are (1) drive in power-off condition, (2) receiver not interconnected with driver, (3) open-circuited interconnecting cable, and (4) short-circuited interconnecting cable. If one of these four fault conditions occurs at the inputs of a receiver, then the output of that receiver is driven to a known logic level. The receiver is programmed by connecting the failsafe input to Vcc or ground. A connection to Vcc provides a logic "1" output

under fault conditions, while a connection to ground provides a logic "0". There are two failsafe pins (Fs1 and Fs2) on the UC5180C where each provides common failsafe control for four receivers.

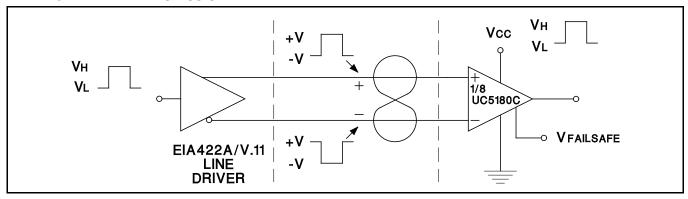
## Input Filtering (UC5180C)

The UC5180C has input filtering for additional noise rejection. This filtering is a function of both signal level and frequency. For the specified input (5.5 MHz at  $\pm 500$  mV) the input stage filter attenuates the signal such that the output stage threshold levels are not exceeded and no change of state occurs at the output.

#### EIA232E/V.28 / EIA423A/V.10 DATA TRANSMISSION



## **EIA422A/V.11 DATA TRANSMISSION**



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